Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/759,415	SCHWARZ ET AL.	
Examiner	Art Unit	
DANH C. LE	2617	

	SEARCHED				
Class	Subclass	Date	Examiner		
455	436 438 439	8/27/06	DCL		
	439				
370	331				
	328				

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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Interference Sourch		8/2/106	DUL			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Sourch. (Check for double patenting) EAST Search updated (US, USPUB, EPU, JPO, DERWEN		DCL		